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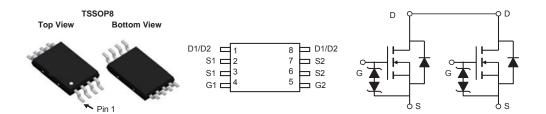
Dual N-Channel 20 V MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)	
20	0.0095 at V_{GS} = 4.5 V	11 ^a	14.5	
	0.0113 at V _{GS} = 2.5 V	9	14.5	

FEATURES

- DT-Trench Power MOSFET
- 100 % R_g Tested
 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC
- ESD Protected 2KV HBM





ABSOLUTE MAXIMUM RATINGS TA	_λ = 25 °C, unless other	wise noted			
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	20	V		
Gate-Source Voltage	V_{GS}	± 12	V		
	T _C = 25 °C		11		
Continuous Drain Current (T. = 150 °C)	T _C = 70 °C	l _D	9.9		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C		10.5 ^{b, c}		
	T _A = 70 °C		8.2 ^{b, c}		
Pulsed Drain Current (10 µs Pulse Width)		I _{DM}	30	А	
Source-Drain Current Diode Current	T _C = 25 °C	- I _S	2.7	A	
Source-Drain Current Diode Current	T _A = 25 °C		1.6 ^{b, c}		
Pulsed Source-Drain Current		I _{SM}	30		
Single Pulse Avalanche Current		I _{AS}	10		
Single Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	10		
	T _C = 25 °C		3.25		
Maximum Power Dissipation	T _C = 70 °C	Б	2.10	W	
	T _A = 25 °C	P _D	2.0 ^{b, c}	VV	
	T _A = 70 °C		1.25 ^{b, c}		
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Тур.	Max.	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	45	62.5	°C/W	
Maximum Junction-to-Foot (Drain)	Steady-State	R _{thJF}	29	38		

Notes:

- a. Based on T_C = 25 °C.
 b. Surface mounted on 1" x 1" FR4 board.
- d. Maximum under steady state conditions is 120 °C/W.

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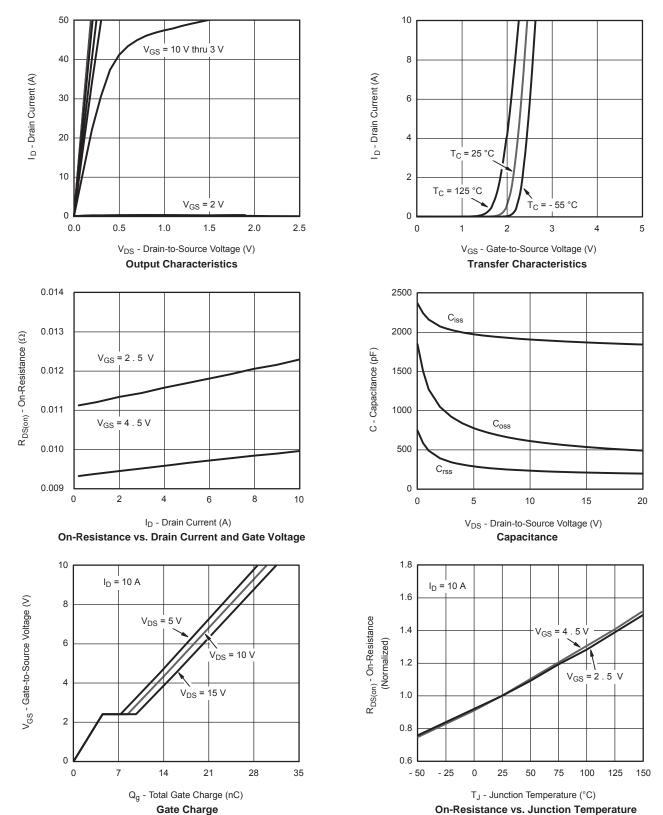
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static					•	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	20			V
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	I _D = 250 μA		20		>//90
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 5.8		mV/°C
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.6		1.2	V
Gate-Body Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ± 8 V			10	uA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 16 V, V _{GS} = 0 V			1	μA
		V _{DS} = 16 V, V _{GS} = 0 V, T _J = 55 °C			10	
On-State Drain Current ^b	I _{D(on)}	V _{DS} = 5 V, V _{GS} = 10 V	11			Α
Drain-Source On-State Resistance ^b	5(0)	V _{GS} = 4.5 V, I _D = 10 A		0.0095	0.0119	Ω
	R _{DS(on)}	V _{GS} = 2.5 V, I _D = 8 A		0.0113	0.0148	
Forward Transconductance ^b	9 _{fs}	V _{DS} = 15 V, I _D = 10 A		50		S
Dynamic ^a					'	l .
Input Capacitance	C _{iss}			2110		
Output Capacitance	C _{oss}	V _{DS} = 10 V, V _{GS} = 0 V, I _D = 1 MHz		926		pF
Reverse Transfer Capacitance	C _{rss}	1		235		
Total Gate Charge	Qg	V _{DS} = 10 V, V _{GS} = 10 V, I _D = 10 A		30	45	nC
				14.5	22	
Gate-Source Charge	Q _{gs}	V _{DS} = 10 V, V _{GS} = 4.5 V, I _D = 10 A		4.5		
Gate-Drain Charge	Q _{gd}	1		3.9		
Gate Resistance	R _g	f = 1 MHz	0.4	1.4	2.8	Ω
Turn-On Delay Time	t _{d(on)}			8	16	
Rise Time	t _r	$V_{DD} = 10 \text{ V, R}_{L} = 1 \Omega$		15	30	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		24	45	
Fall Time	t _f	1		9	18	
Turn-On Delay Time	t _{d(on)}			18	35	ns
Rise Time	t _r	V _{DD} = 10 V, R _I = 1 Ω		24	45	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		26	50	
Fall Time	t _f	1		13	26	
Drain-Source Body Diode Characteristi	cs				'	
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			2.7	A
Pulse Diode Forward Current ^a	I _{SM}				30	
Body Diode Voltage	V _{SD}	I _S = 3 A		0.70	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			20	40	ns
Body Diode Reverse Recovery Charge	Q _{rr}	N-Channel		10	20	nC
Reverse Recovery Fall Time	t _a	$I_F = 10 \text{ A, dl/dt} = 100 \text{ A/µs, T}_J = 25 ^{\circ}\text{C}$		11	İ	
Reverse Recovery Rise Time	t _b	1		9		nS

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



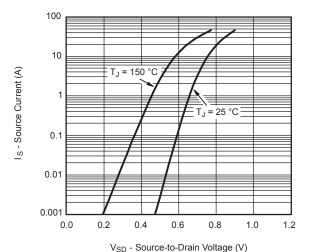


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

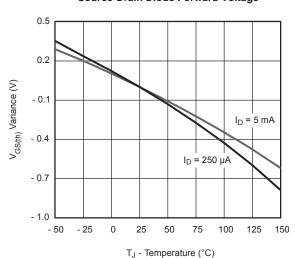




TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Source-Drain Diode Forward Voltage

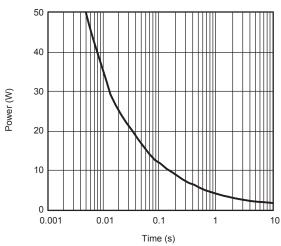


Threshold Voltage

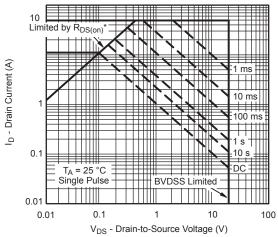
0.020 I_D = 10 A 0.016 $R_{DS(on)}$ - On-Resistance (Ω) 0.012 0.008 T_J = 125 °C 0.004 T_J = 25 °C 0.000 0 1 2 3 4 5 6 7 8 9 10

V_{GS} - Gate-to-Source Voltage (V)

On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

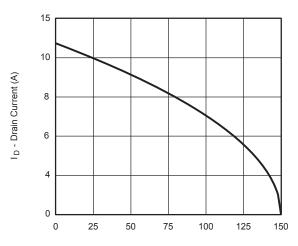


* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

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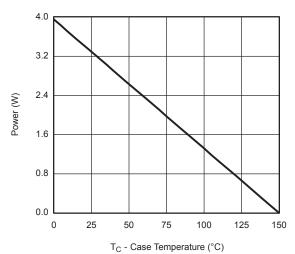
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

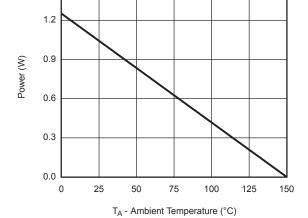


T_C - Case Temperature (°C)

1.5

Current Derating*





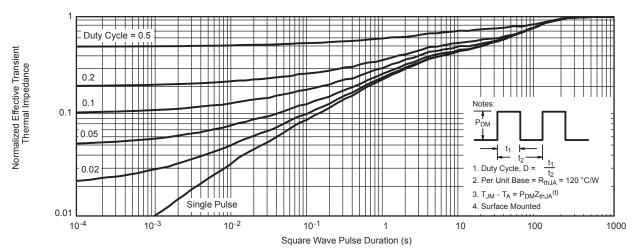
Power Derating, Junction-to-Foot

Power Derating, Junction-to-Ambient

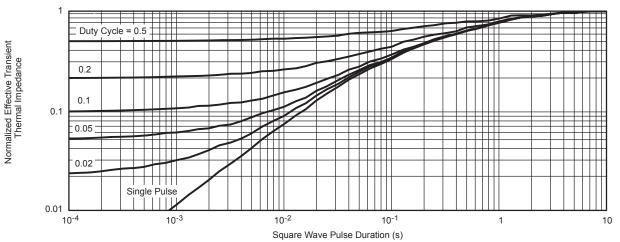
 $^{^*}$ The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot



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